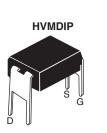
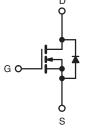




Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	100				
R _{DS(on)} (Ω)	V _{GS} = 5.0 V 0.54				
Q _g (Max.) (nC)	6.1				
Q _{gs} (nC)	2.6				
Q _{gd} (nC)	3.3				
Configuration	Sing	le			





N-Channel MOSFET

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- Logic-Level Gate Drive
- $R_{DS(on)}$ Specified at $V_{GS} = 4 V$ and 5 V
- 175 °C Operating Temperature
- Material categorization: For definitions of compliance please see <u>www.vishay.com/doc?99912</u>

Note

* Lead (Pb)-containing terminations are not RoHS-compliant. Exemptions may apply.

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION	
Package	HVMDIP
Load (Db) free	IRLD110PbF
Lead (Pb)-free	SiHLD110-E3
SnPb	IRLD110
SNPD	SiHLD110

ABSOLUTE MAXIMUM RATINGS (TA	= 25 °C, unle	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	100	V	
Gate-Source Voltage			V _{GS}	± 10		
Continuous Drain Current	V _{GS} at 5.0 V	T _A = 25 °C	I.	1.0		
	v _{GS} at 5.0 v	T _A = 100 °C	ID	0.70	А	
Pulsed Drain Current ^a			I _{DM}	8.0	1	
Linear Derating Factor				0.0083	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	100	mJ	
Avalanche Current ^a			I _{AR}	1.0	А	
Repetitive Avalanche Energy ^a			E _{AR}	0.13	mJ	
Maximum Power Dissipation $T_A = 25 \text{ °C}$		PD	1.3	W		
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	- °C		
Soldering Recommendations (Peak Temperature) for 10 s			300 ^d			

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. V_{DD} = 25 V, starting T_J = 25 °C, L = 6.4 mH, R_g = 25 Ω , I_{AS} = 5.6 A (see fig. 12).

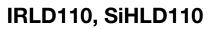
c.
$$I_{SD} \le 5.6$$
 A, $dI/dt \le 75$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.

d. 1.6 mm from case.

S12-0617-Rev. D, 26-Mar-12

Document Number: 91309







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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	120	°C/W	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$		100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.12	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	: V _{GS} , I _D = 250 μΑ	1.0	-	2.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 10 V	-	-	± 100	nA
Zero Coto Voltago Droin Current		V _{DS} =	= 100 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 80 V	$V_{GS} = 0 \text{ V}, \text{ T}_{J} = 150 ^{\circ}\text{C}$	-	-	250	μA
	Р	$V_{GS} = 5.0 V$	I _D = 0.60 A ^b	-	-	0.54	Ω
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 4.0 V$	I _D = 0.50 A ^b	-	-	0.76	
Forward Transconductance	9 _{fs}	V _{DS} =	50 V, I _D = 0.60 A ^b	1.3	-	-	S
Dynamic		<u>.</u>					
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	250	-	
Output Capacitance	C _{oss}		$V_{\rm DS} = 25 V,$		80	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.	0 MHz, see fig. 5	-	15	-	
Total Gate Charge	Qg			-	-	6.1	
Gate-Source Charge	Q _{gs}	$V_{GS} = 5.0 V$	$I_D = 5.6 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 ^b	-	-	2.6	nC
Gate-Drain Charge	Q _{gd}		see lig. o and to	-	-	3.3	
Turn-On Delay Time	t _{d(on)}			-	9.3	-	
Rise Time	t _r	$ \begin{array}{c c} & V_{DD} = 50 \text{ V}, \text{ I}_D = 5.6 \text{ A}, \\ \hline R_g = 12 \Omega, R_D = 8.4 \Omega, \text{ see fig. } 10^b & - 16 \\ \hline & - 17 \end{array} $		-	4.7	-	- ns
Turn-Off Delay Time	t _{d(off)}			-	16	-	
Fall Time	t _f			-	1		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from		-	4.0	-	
Internal Source Inductance	L _S	 package and die contact 	center of	-	6.0	-	nH
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	I _S	MOSFET sym showing the	MOSFET symbol		-	1.0	
Pulsed Diode Forward Current ^a	I _{SM}	integral revers p - n junction		-	-	8.0	A
Body Diode Voltage	V _{SD}	T _J = 25 °C	, I _S = 1.0 A, V _{GS} = 0 V ^b	-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}			-	110	130	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_1 = 25 \text{ °C}$, $I_E = 5.6 \text{ A}$, $dI/dt = 100 \text{ A/us}^b$		0.65	μC		
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time is negligible (turn	-on is dor	ninated b	v Ls and	Ln)

Notes

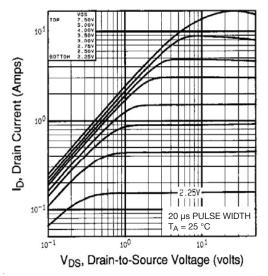
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





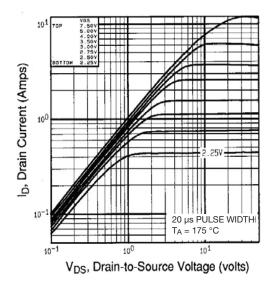


Fig. 2 - Typical Output Characteristics, $T_A = 175 \ ^\circ C$

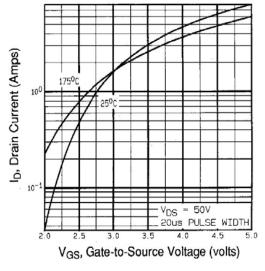


Fig. 3 - Typical Transfer Characteristics

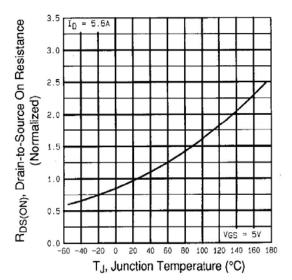


Fig. 4 - Normalized On-Resistance vs. Temperature



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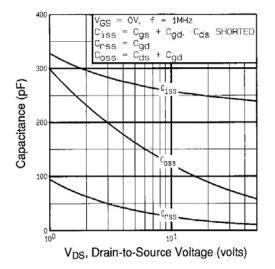
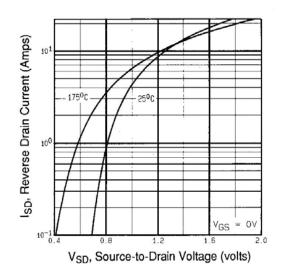
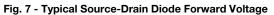


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





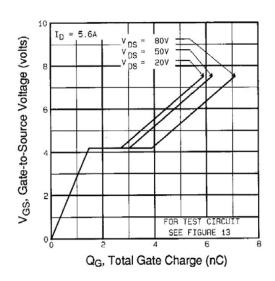


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

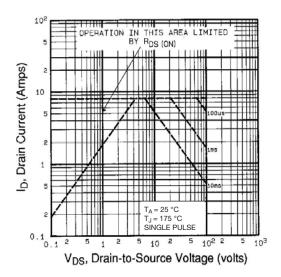


Fig. 8 - Maximum Safe Operating Area



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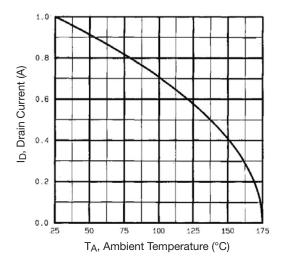


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

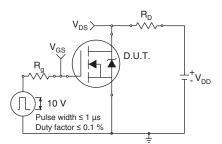


Fig. 10 - Switching Time Test Circuit

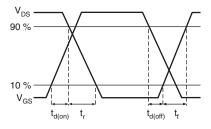


Fig. 11 - Switching Time Waveforms

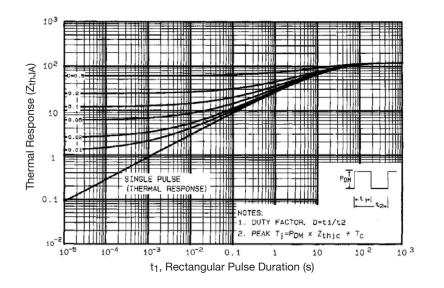


Fig. 12 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient





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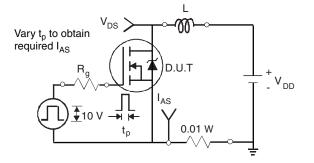


Fig. 13 - Unclamped Inductive Test Circuit

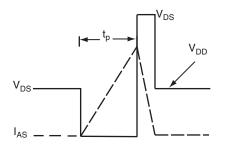


Fig. 14 - Unclamped Inductive Waveforms

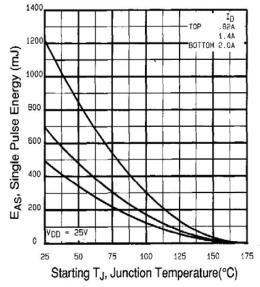
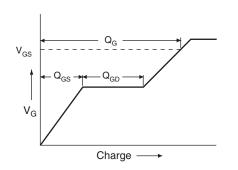


Fig. 15 - Maximum Avalanche Energy vs. Drain Current





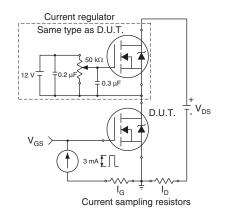
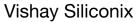
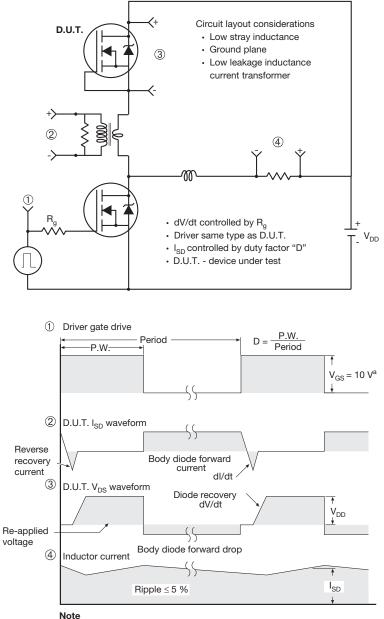


Fig. 17 - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5$ V for logic level devices

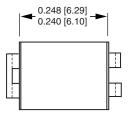
Fig. 18 - For N-Channel

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HVM DIP (High voltage)





INC		HES	MILLIMETERS	
DIM.	MIN.	MAX.	MIN.	MAX.
А	0.310	0.330	7.87	8.38
E	0.300	0.425	7.62	10.79
L	0.270	0.290	6.86	7.36
ECN: X10-0386-Rev. B, 0 DWG: 5974	06-Sep-10			

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.



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